Notice of References Cited Application/Control No. 10/774,720 Applicant(s)/Patent Under Reexamination BOYEN, XAVIER Examiner TRANG DOAN Applicant(s)/Patent Under Reexamination Art Unit Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2002/0018569 A1	02-2002	Panjwani et al.	380/247
*	В	US-6,396,928 B1	05-2002	Zheng, Yuliang	380/285
*	C	US-2003/0081785 A1	05-2003	Boneh et al.	380/277
*	D	US-2003/0179885 A1	09-2003	Gentry et al.	380/277
*	Е	US-2004/0003270 A1	01-2004	Bourne et al.	713/193
*	F	US-6,792,530 B1	09-2004	Qu et al.	713/156
*	G	US-6,834,112 B1	12-2004	Brickell, Ernie F.	380/279
*	Ι	US-6,910,129 B1	06-2005	Deng et al.	713/171
*	I	US-6,950,523 B1	09-2005	Brickell et al.	380/286
*	٦	US-7,353,395 B2	04-2008	Gentry et al.	713/171
*	К	US-RE40,687 E	03-2009	Oshima et al.	380/201
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	\ \					
	w					
	х					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.